

Fabric Defect Detection Using Sparse representation Algorithm

M.Fathu Nisha

Roomi

K.L.N.College of Information
Technology
Madurai, India
mfnish@rediffmail.com

Dr.P.Vasuki

K.L.N.College of Information
Technology
Madurai, India

Dr.S.Mohamed Mansoor

Thiagarajar College of
Engineering
Madurai, India

Abstract— In fabric manufacturing technology, many types of fabric defects occur during production. These defects still detected by human inspection. But this system led to several disadvantages. To solve these drawbacks, machine vision based techniques are designed to detect the defects. In this paper, proposed fabric inspection model consists of image pre processing, feature extraction, defect detection and classification. The image pre processing improves the image contrast in order to make the details of defects more clear. Denoising techniques used to remove the noise and increase the quality of the image. Non locally centralized sparse representation algorithm is employed for defect detection and multi svm method used for defect classification. This model has high detection accuracy and low false alarm. It is suitable for identification of tiny defects, especially oil stain, ink stain, soil stain.

Index Terms--- Fabric detection; defect classification; Fabric Inspection module;

I INTRODUCTION

Traditionally fabric detection based on visual inspection, which is expensive and low efficiency [1-4]. Its disadvantages are overcome by automated fabric inspection system. For automated fabric inspection system, previous authors proposed numerous approaches such as statistical, spectral, model based, learning, structural [5-7] and many techniques such as fourier transform, gabor transform, wavelet transform, GLCM, Bollinger bands. Structural approaches consider texture as

composition of textural primitives. Texture analysis is performed by two steps. Obtaining the texture features is the first step, and inferring their replacement rules is the second step. By this texture analysis approach, the overall texture of the pattern can be obtained with the composition of simple texture structures. Structural texture analysis consists of two stages. First stage is fabric texture detection. Second stage is overall fabric texture pattern modeling. Disadvantage of this approach is low reliability. This method is reliable in fabric defect segmentation in which texture pattern is very regular. Statistical methods [8-15] use first order statistics and second order statistics to extricate textural features in texture classification. Methods includes in this approach are co- occurrence matrix, histogram features, auto correlation function, mathematical morphology, cross correlation, statistical moments and edge detection.

Spectral approaches extract and generalize the fundamentals of image texture with the spatial layout rules. Wavelet transform [16-17], Fourier transform [18], Gabor transform [19-21] are the methods of spectral approaches. Wavelet transform discern the fabric defects of missing ends, missing picks, broken fabrics, and oil stains.

In this paper, a novel detection model, which is based on non-locally centralized sparse representation, is used for fabric defect identification. The proposed detection model includes four main parts: pre processing, dictionary learning, sparse coding [22-34] and defect segmentation. In pre processing, gray level conversion is employed to reduce noise formed by

digital imaging and increase the contrast between defects and background. In the dictionary learning process, training samples are divided into K clusters by K -means clustering [35]. Compact sub dictionary will be formed for each cluster by using principal component analysis method. Defects are finally segregated from the residual image of the testing image and the corresponding restored image. Multi SVM technique used for classification of defects. [37- 42]

II RELATED WORKS

Jiancho yang et al. presented a new approach to single image super resolution, based upon sparse signal representation. Sparse representation for each patch of the low resolutions input is fixed. Then the coefficients of this representation are used to generate the high resolution output. This algorithm generates gray level relationship among s high resolution images that are competitive and superior in quality to images produced by other similar super resolution methods. Sparse modeling of this approach is robust to noise. This algorithm can be handle super resolution with noisy inputs in a more unified frame work.

Julian mairal et al. developed two different approaches for image restoration. First approach is learning a basis set (dictionary) adapted to sparse and classification tasks.

Second approach is exploiting the self similarities of natural images has led to the successful non local means approach for image restoration. For combining these two approaches in a natural manner, simultaneous sparse coding is proposed as a frame work. This is achieved by jointly decomposing groups of similar signals on subsets of the learned dictionary. This method effectively restores raw images from digital cameras at a high speed and low cost. This method applied in denoising and demosaicing tasks.

Ignacio Ramirez et al. proposed a frame work for designing sparse modeling priors was introduced. Universal coding tools formalize sparse coding and modeling from minimum description length (MDL)

principle. The obtained priors lead to models both theoretical and practical advantages over the traditional one. This method used in the recovery of sparse signal, image denoising, and classification applications.

Kumar and Pang have proposed fabric inspection models based on a gabor filter bank. This gabor filter bank consists of 24 gabor filters. These gabor filters was generated at four scales and six orientations to detect the defects on the fabric. This method is based on the multi resolution analysis. Defect features were represented by fusing the outputs of all gabor filters. Parameters defined empirically, implementation of this detection model is easy. Here drawback is gabor filtering generate large amount of data, which disturbs texture discrimination.

III METHODS

A. *Image pre processing*

Fabric is synthetic material. It having fine weaving structure, made by fine raw materials. When the contrast between defect and the back ground of fabric is minimum, the discrimination of normal fabric and defects is a complicated task. Fabric material easily absorbs dust in the air and fabric images are affected by noise.

Noise appearing as bright dots or dust particles. It degrades or distorts the image quality. Noise can be fixed valued or random valued. These noises are mistakenly identified as defect pattern and therefore noise to be removed.

During image acquisition, inhomogeneties occur due to variance in relative position of the light source, camera position, and the textile position. These inhomogeneties make some part of the image appear darker and many have uneven contrast. To solve these issues, contrast enhancement is applied. Adaptive histogram equalization is a valid method of contrast enhancement which provides adequate contrast in local areas than traditional histogram equalization methods.

B. Dictionary learning using KPCA

Clustering is a mostly used searching tool whose main task is to identify and group similar objects together. K means algorithm is one of the most used clustering algorithm which divide S observations in K clusters in which each observation belongs to the cluster with the nearest mean.

Non defective fabric images are portioned into small patches which are clustered based on their structural

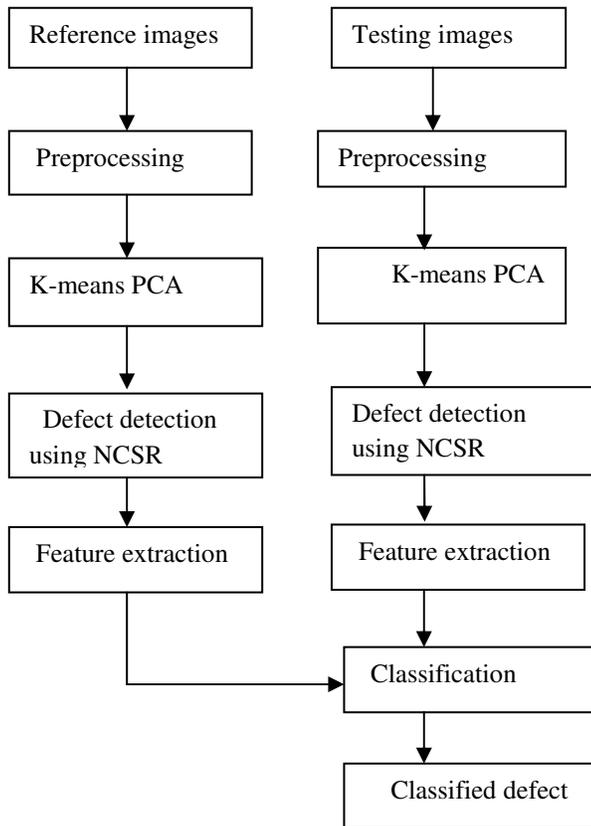


Fig.1. Flowchart of the defect detection process includes dictionary learning and detection model

fabric texture element. Sparse representation used to find a linear combination of a small number of basic atoms to restore the signal with minimum approximation error. Dataset is taken as S means, it can be divided into K clusters and, sub dictionary learned from each clusters.

PCA is a de-correlation based method which is suitable for learning sub dictionaries that finds a linear transformation W on a multi variant data X

represented as $X'=WX$ Principal component analysis is a signal de-correlation and dimensionality reduction technique. This method extracts the principal components of a set of possibly correlated data. This data revealed the internal structure of the data. In this proposed model, PCA scheme is applied on each cluster of image patches, for achieving a set of values of linearly un correlated variables. This variable composes a compact dictionary. This dictionary is sufficient for sparse representation of an image patch. This scheme reduces the computation cost. All sub dictionaries together formed an over complete dictionary that characterizes all the possible local structures of fabric images.

KPCA is a method for speeding up feature extraction and it is an improved PCA. This scheme widely used for non linear feature extraction. KPCA is applied to dimensionality reduction of the feature vectors. KPCA maps the high dimension features in the input space to new lower dimension eigen space through a non linear mapping. Principal component analysis scheme is used to find a set of eigen vectors which are non linearly related to the input data.

Algorithm proceeds as follows,

1. Pick k random points as cluster centre positions.
2. Assign each point to the nearest centre.
3. Recompute each cluster mean as the mean of the vectors assigned to that cluster.
4. If centers moved go to 2. The algorithm requires a distance measure to be defined in the data space and euclidean distance is used.

C. Defect detection using NCSR

For defect detection, Non locally Centralized Sparse Representation (NCSR) method is applied. In NCSR, each patch is coded using adaptive sparse domain selection strategy method.

D. Local binary pattern method for feature extraction

Local binary pattern is a easiest, efficient, and accurate method for detecting defects in fabric. This

algorithm used to extract the feature value of fabric image. The basic idea is built on pixels. Relative gray value obtained by comparing the gray values of the center pixel with its surrounding neighborhood pixels, relative gray value can be obtained as the

E. Multi SVM classification

The features pull out from the local binary pattern method are used to train the support vector machines. Support vector machine is a binary classification method by supervised learning. It finds a classifier that separates the training data and to maximize the distance between two classes. SVM based multi class pattern recognition technique employed for inspecting frequently occurring fabric defects.

There are two types of approaches used for the extension of binary two class problem to n class problem .first approach is to qualify the design of the SVMs to unite the multi class learning in the quadratic solving algorithm.

Second approach is methods like one against all and one against one have been proposed, where multi class classifier is constructed by combining binary classifiers.

IV RESULTS AND DISCUSSION

response of the center pixel. LBP is invariable for monotonic gray scale changes. LBP is a combination

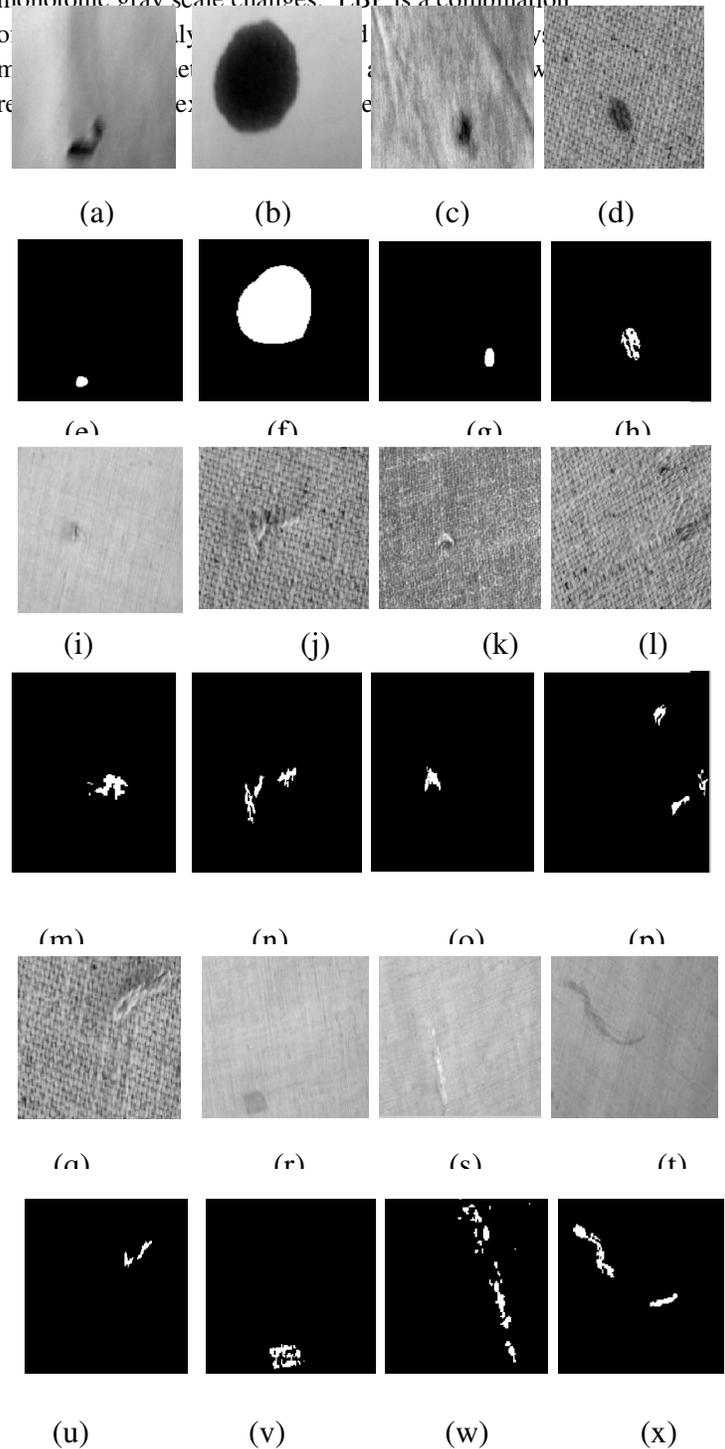


Fig.2. Detection results of fabric images

The performance of the proposed fabric detection is done using TILDA data base which is created by a texture analysis workshop of deutsche forschungs gemeins chaft germany. [36]. This data base contains most common types of defects that always appear in the textile industry.

In this paper, the following four measurements (expressed as percentages) are used to judge the performance of defect detection models.

- 1) **Precision** = $TA / TA+FA$
- 2) **Sensitivity** = $TA / TA+FN$
- 3) **Specificity** = $TN / TN+FA$

VI CONCLUSION

In lassification based on non-locally centralized sparse representation has been proposed. This model is mainly based on two modules: dictionary learning (off-line) and dedefect detection through image restoration (real time). The proposed inspection module efficiently locate the defect and outlined their accurate shape even the fabric

VII. REFERENCES

- [1] R.Stojanovic, P.Mitropulos, C.Koulamas Y.Karayiannis, S.Koubias, and G.Papadopoulos "Real time vision based system for textile fabric inspection", Real Time Imaging, vol.7, no.6, pp.507-518, 2001.
- [2] C.S.Cho, B.M.Chung, and M.J.Park, "Development of real time vision based fabric inspection system", "IEEE Transactions on Industrial Electronics, vol.52, no.4, pp. 1073-1079, 2005.
- [3] J.L.Raheja, B.Ajay and A.Chaudhary, "Real time fabric defect detection system on an embedded dsp platform", Optik International Journal for Light Electron Optics, vol.124, no.21, pp.5280-5284, 2013.
- [4] W.Du, Y.Tang, S.Y.S.Leung, L.tong, A.V.Vasilakos, and F.Qian, "Robust order scheduling

$$4) \text{ Accuracy} = TA+TN / TA+TN+FA+FN$$

. False abnormal means white pixels appear in the binary feature image of a defect free sample. True normal means white pixels not appeared in defect free sample. False normal means white pixels is not appeared in the binary image though it is affected by defect.

Precision defined as the percentage of correct alarm during detection, sensitivity defined as the percentage of defective samples that are correctly identified, specificity defined as the percentage of defect free images that are correctly classified as normal, accuracy defined as the percentage of correct classification of all testing images. Figure 2 shows detection results of some tiny defect samples.

structure is slightly more complex than others. TILDA data base and some more real fabric samples are used for detection process. This inspection module achieved better performance for small fabric defects. This model achieved better detection accuracy.

in the fashion industry:a multi objective optimization approach", IEEE Transactions on Industrial Informatics, to be published doi: 10.1109/TII.2017.2664080.2017.

- [5] H.Y.T.Ngan, G.K.H.Pang and N.H.C.Yung, "Automated fabric defect detection –a review", Image and vision Computing, vol.29, no.7, pp.442-458, 2011.
- [6] A.Kumar, "Computer vision based fabric defect detection: a survey", IEEE Transactions on Industrial Electronics , vol.55, no.1, pp. 348-363, 2008.
- [7] Kazim Hanbay, Muhammed Faith Talu, Omer Faruk Ozguven, "Fabric defect detection systems and methods- A systematic literature review", Elsevier, Optik127, 11960-11973, 2016.

- [8] K Hanbay, M.F.Talu, O.F.Ozguven , D.Ozturk, Fabric defect detection methods for circular knitting machines, in:23rd Signal Processing and Communications Applications Conference (SIU) Malatya, pp.735-738. 2015.
- [9] Dandan Zhu, Ruru pan, Weidong gau, Jie zhang, “Yarn dyed fabric defect detection based on auto correlation function and GLCM”, Autex Research Journal, DoI; 10.1515/aut-0001, pp.1-7, 2015.
- [10] Hui-Fuang Ng, Automatic thresholding for defect detection, Pattern Recognit.Lett 27 (14) 1644-1649, 2006.
- [11] K.Hoshino, H.Sumi, T.Nishimura, “Noise detection and reduction for image sensor by time domain autocorrelation function method, IEEE International Symposium on Industrial Electronics, pp.1737-1740, 2007.
- [12] A.Tilocca, P.Borzoone, S.Carosio, A.Durante, “Detecting fabric defects with a neural network using two kinds of optical patterns. Text.Res.J.72, 2002.
- [13] K.L.Mak, P.Peng, K.F.C.Yiu, “Fabric defect detection using morphological filters, image Vision Computing, 27, 1585-1592, 2009.tem graduate research colloquium (ICSGRC), 197-202, 2012.
- [14] V.Jayashree, S.Subbaramn, “Hybrid approach using correlation and morphological approaches for GFDD of plain weave fabric, IEEE Controland sy
- [15] H.Ibrahim Celik, L.Canan Dulgr, Mehmet Topalbekiroglu, “Fabric defect detection using linear filtering and morphological operations”, Indian Journal of Fiber and Textile Research, vol.39, pp.254-259, 2014.”
- [24] Le Tong, W.K. Wong, C.K.Kwong, “Fabric defect detection for apparel industry: A non local sparse representation approach”, IEEE trans.Image Proc.,2017.
- [25] Julien Mairal, Francis Bach, Jean Ponce, Gullermo Sapiro, Andrew Zisserman, “Non-local sparse models for image restoration”, IEEE 12th
- [16] G.H.Hu,Q.H.Wang, G.H.Zhang, “Unsupervised defect detection in textiles based on fourier analysis and wavelet shrinkage, Applied optics, vol.54, no.10, pp.2963-2980, 2015.
- [17] S.D.Kim, S.Udpa, “Texture classification using rotated wavelet filters”, IEEE transactions on systems, man, and cybernetics-part A:systems and humans, vol.30, no.6, pp.847-852, 2000.
- [18] C.h.Chan, G.K.H.Pang, “Fabric defect detection by fourier analysis, IEEE Transactions on Industry Applications, vol.36, no.5, pp.1267-1276, 2000.
- [19] Lucia Bissi, Giuseppe Baruffa, PisanaPlacidi, Elisa ricci, Andrea siorzoni, paolo valigi, “Automated defect detection in uniform and structural fabrics using gabor filters and PCA”, Elsevier, J.Vis Commun.Image, R.24, 838-845, 2013.
- [20] Ajay kumar, grantham K.H.Pang, “Defect detection in Textured materials using Gabor filters”, IEEE Transactions on Industry applications, vol.38, no.2, pp.425-440, 2002.
- [21] L. Tong, W.Wong, C.Kwong, “Differential evolution based optimal Gabor filter model for fabric inspection, Elsevier, Neuro computing, vol.173, pp.1386-1401, 2016.
- [22] Hicham Badri, Hussein Yahia, Driss Aboutajdine, “Low rankness transfer for realistic denoising”, IEEE Transactions on Image processing, pp.1-12, 2016.
- [23] J.X. Yang, Y.Q.Zhao, J.C.W.Chan, S.G.Kong, “Coupled sparse denoising and un mixing with low rank constraint for hyper spectral image ”, IEEE Transctions on Geo science and Remote Sensing , vol.54, no.3, pp.1818-1833,2016.
- International conference on computer vision, pp.2272-2279, 2009.
- [26] Ignacio Ramirez, guillermo Sapiro, “Universal regularizers for robust sparse coding and modeling”, IEEE Trans. On Image Process., vol.21, no.9, pp.3850-3864, 2012.

- [27] Jianchao Yang, John Wright, Thomas S.Huang, Yi Ma, “Image super resolution via sparse representation”, IEEE Trans. On image Process., vol.19, no.11, pp.2861-2873, 2010.
- [28] J.Zhou, and J.Wang, “Fabric defect detection using adaptive dictionaries,” Textile Research Journal, pp.1846-1859, 2013.
- [29] Ron Rubinstein, Alfred M.Bruckstein, Michael elad, “ Dictionaries for sparse representation modeling”, Proceedings of IEEE, vol.98, no.6, pp.1045-1057, 2010.
- [30] Michal Aharon, Michael Elad, Alfred Bruckstein, “K-SVD:An Algorithm for designing overcomplet dictionaries for sparse representation”, IEEE Transactions on signal processing, vol.54, no.11, pp.4311-4322, 2006.
- [31] Weisheng Dong, Lei Zhang, Guangming Shi, Xin Li, “ Nonlocally centralized sparse representation for image restoration”, IEEE Transactions on image processing, vol.22, no.4, pp.1620-1630, 2013.
- [32] Michael Elad, Irad Yavneh, “A plurality of sparse representations is better than the sparsest one alone”, IEEE Transactions on information theory, vol.55, no.10, pp.4701-4714, 2009.
- [33] By Joel A.Tropp, Stephen J.Wright, “Computational methods for sparse solution of linear inverse problems”, Proceedings of IEEE, vol.98, no.6, pp.948-958, 2010.
- [34] Weisheng Dong, Lei Zhang, Guangming Shi, Xialin Wu, “Image deblurring and super resolution by adaptive sparse domain selection and adaptive regularization”, IEEE Transactions on image processing, vol.20, no.7, pp.1838-1857, 2011.
- [35] Aiguo song, Yezhen Han, Haihua Hu, Jianqieng, Li, “A.Novel Texture sensor for fabric texture measurement and classification”, IEEE Transactions on Instrumentation and measurement, vol.63, no.7, pp.1739-1747, 2014.
- [36] D.F.Germany, Tilda textile texture database, “<http://lmb.informatik.uni-freiburg.de/resources/datasets/tilda.en.html>.Version 1.0,1996.
- [37] Wei Wang, Min Zhang, Dan Wang, Yu Jiang, “Kernal PCA feature extraction and the SVM classification algorithm for multi –status, through-Wall , human being detection, Springer- EURASIP Journal on Wireless Communications and Networking, pp.1-7, 2017.
- [38] A.Ghosh, T.Guha, “Pattern Classification of fabric defects using support vector machines”, International Journal of Clothing Science and Technology, Vol.23, No.2/3, pp.1-7, 2011.
- [39] Gi-Sung Cho, Narangerel Gantulaga, Yun-Woong choi , “ a Comparative study on multiclass SVM & kernal function for land cover classification in a KOMPSAT-2 image”, Springer- KSCE Journal Civil Engineering, pp.1894-1904, 2017.
- [40] Urun Dogan, Tobias Glasmachers, Christian Igel, “ A unified view on multi class support vector classification, Journal of Machine Learning Research, pp. 1-32, 2016.
- [41] Haydemar Nunez, Luis Gonzalez, Ceclilio Angulo, “Improving SVM classification on imbalanced datasets by d a new bias” Journal of Classification, 34:pp.427-443, 2017.
- [42] critanini,.N, Shawe-Taylor.J, An Introduction to support vector machines and other kernel based learning methods, Cambridge Universtiy Press, Cambridge.